

<b>Search Notes</b> 	<b>Application/Control No.</b>  10/601,907	<b>Applicant(s)/Patent under Reexamination</b>  KIM ET AL.
<b>Examiner</b>  Julian Mercado	<b>Art Unit</b>  1745	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Philips	Interference	1/1/01	PM
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